

100364

OBSOLETE May 15, 2009

Low Power 16-Input Multiplexer

General Description

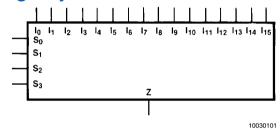
The 100364 is a 16-input multiplexer. Data paths are controlled by four Select lines (S_0-S_3) . Their decoding is shown in the truth table. Output data polarity is the same as the seleted input data. All inputs have 50 k Ω pulldown resistors.

- 2000V ESD protection
- Pin/function compatible with 100164
- Voltage compensated operating range = -4.2V to -5.7V
- Available to industrial grade temperature range
- Standard Microcircuit Drawing (SMD) 5962-9459201

Features

■ 35% power reduction of the 100164

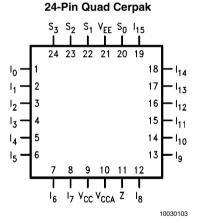
Logic Symbol



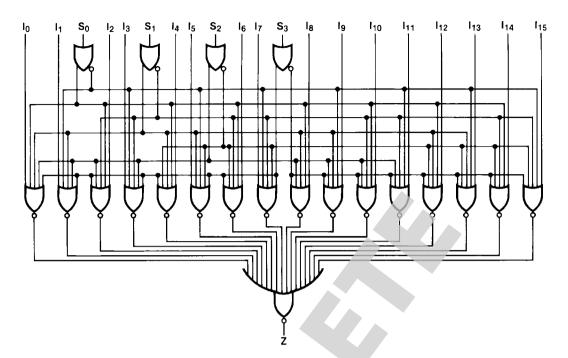
Pin Names	Description
I ₀ -I ₁₅	Data Inputs
S_0-S_3	Select Inputs
Z	Data Output

Connection Diagrams

24-Pin DIP 24 23 22 •S₃ 20 19 -S 18 8 Z 17 10 وا 110 12



Logic Diagram



10030105

Truth Table

	Output			
S ₀	S ₁	S ₂	S ₃	Z
L	L	L	L	I ₀
Н	L	L	L	I ₁
L	Н	L	L	l ₂
Н	н	L	L	l ₃
L	L	Н	L	I ₄
Н	L	Н	L	I ₅
L	н	Н	н L	
Н	н	Н	L	l ₇
L	L	L	Н	I ₈
Н	L	L	Н	l ₉
L	н	L	Н	I ₁₀
Н	н	L	Н	I ₁₁
L	L	Н	Н	I ₁₂
Н	L	Н	Н	I ₁₃
L	н	н	Н	I ₁₄
Н	н	Н	Н	I ₁₅

H = HIGH Voltage Level L = LOW Voltage Level

Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Above which the useful life may be impaired

Storage Temperature (T_{STG}) $-65^{\circ}C$ to +150°C

Maximum Junction Temperature (T₁)

Ceramic +175°C

Pin Potential to

Ground Pin (V_{EE}) -7.0V to +0.5V

Input Voltage (DC)

V_{EF} to +0.5V

Output Current

(DC Output HIGH) -50 mA ESD (Note 2) ≥ 2000V

Recommended Operating Conditions

Case Temperature (T_C)

Military -55°C to $+125^{\circ}\text{C}$ Supply Voltage (V_{EE}) -5.7V to -4.2V

Note 1: Absolute maximum ratings are those values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: ESD testing conforms to MIL-STD-883, Method 3015.

Military Version DC Electrical Characteristics

 $V_{EE} = -4.2V$ to -5.7V, $V_{CC} = V_{CCA} = GND$, $T_{C} = -55^{\circ}C$ to $+125^{\circ}C$

Symbol	Parameter	Min	Max	Units	T _C	Condi	tions	Notes
V _{OH}	Output HIGH Voltage	-1025	-870	mV	0°C to	$V_{IN} = V_{IH} (Max)$	Loading with	(Notes 3, 4, 5
					+125°C	or V _{IL} (Min)	50Ω to -2.0V	
		-1085	-870	mV	−55°C			İ
V _{OL}	Output LOW Voltage	-1830	-1620	mV	0°C to			
					+125°C			
		-1830	-1555	mV	−55°C			
V _{OHC}	Output HIGH Voltage	-1035		mV	0°C to	$V_{IN} = V_{IH} (Min)$	Loading with	(Notes 3, 4, 5
					+125°C	or V _{IL} (Max)	50Ω to -2.0V	
		-1085		mV	−55°C	7		
V _{OLC}	Output LOW Voltage		-1610	mV	0°C to			
					+125°C			
			-1555	mV	−55°C			
V _{IH}	Input HIGH Voltage	-1165	-870	mV	−55°C to	Guaranteed HIGH Signal		(Notes 3, 4, 5
					+125°C	for All Inputs		6)
V_{IL}	Input LOW Voltage	-1830	-1475	mV	−55°C to	Guaranteed LOW Signal (No for All Inputs		(Notes 3, 4, 5
					+125°C			6)
I _{IL}	Input LOW Current	0.50		μΑ	−55°C to	$V_{EE} = -4.2V$		(Notes 3, 4, 5
					+125°C	$V_{IN} = V_{IL} (Min)$		
I _{IH}	Input HIGH Current		300	μΑ	0°C to	$V_{EE} = -5.7V$		(Notes 3, 4, 5
					+125°C	$V_{IN} = V_{IH} (Max)$		
			450	μΑ	−55°C			
I _{EE}	Power Supply Current	-95	-35	mA	−55°C to	Inputs Open		(Notes 3, 4, 5
					+125°C			

Note 3: F100K 300 Series cold temperature testing is performed by temperature soaking (to guarantee junction temperature equals –55°C), then testing immediately without allowing for the junction temperature to stabilize due to heat dissipation after power-up. This provides "cold start" specs which can be considered a worst case condition at cold temperatures.

Note 4: Screen tested 100% on each device at $-55^{\circ}C$, $+25^{\circ}C$, and $+125^{\circ}C$, Subgroups, 1, 2, 3, 7 and 8.

Note 5: Sampled tested (Method 5005, Table I) on each manufactured lot at -55°C, +25°C, and +125°C, Subgroups A1, 2, 3, 7 and 8.

Note 6: Guaranteed by applying specified input condition and testing V_{OH}/V_{OL} .

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AC Electrical Characteristics

 V_{EE} = -4.2V to -5.7V, V_{CC} = V_{CCA} = GND

Symbol	Parameter	T _C = -	-55°C	T _C =	25°C	T _C = +	-125°C	Units	Conditions	Notes
		Min	Max	Min	Max	Min	Max	1		
t _{PLH}	Propagation Delay	0.50	2.60	0.60	2.40	0.60	2.80	ns	Figures 1, 2	(Notes 7, 8,
t _{PHL}	I ₀ -I ₁₅ to Output									9)
t _{PLH}	Propagation Delay	0.70	3.30	0.90	3.10	1.00	3.50	ns		
t _{PHL}	S ₀ , S ₁ to Output									
t _{PLH}	Propagation Delay	0.50	2.90	0.70	2.60	0.60	3.00	ns		
t _{PHL}	S ₂ , S ₃ to Output									
t _{TLH}	Transition Time	0.20	1.20	0.20	1.20	0.20	1.20			(Note 10)
t _{THL}	20% to 80%, 80% to 20%							ns		

Note 7: F100K 300 Series cold temperature testing is performed by temperature soaking (to guarantee junction temperature equals –55°C), then testing immediately without allowing for the junction temperature to stabilize due to heat dissipation after power-up. This provides "cold start" specs which can be considered a worst case condition at cold temperatures.

Note 8: Screen tested 100% on each device at +25°C, temperature only, Subgroup A9.

Note 9: Sample tested (Method 5005, Table I) on each Mfg. lot at +25°C, Subgroup A9, and at +125°C, and -55°C temp., Subgroups A10 and A11.

Note 10: Not tested at +25°C, +125°C and -55°C temperature (design characterization data)

Test Circuit

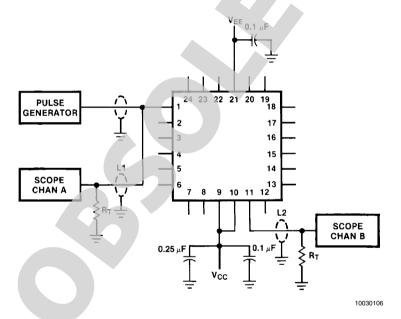
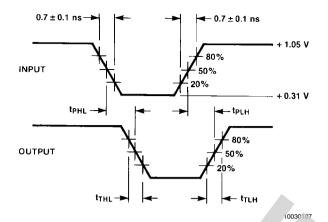


FIGURE 1. AC Test Circuit

Switching Waveforms



Note 11: V_{CC} , $V_{CCA} = +2V$, $V_{EE} = -2.5V$

Note 12: L1 and L2 = Equal length 50Ω impedance lines

Note 13: $R_T = 50\Omega$ terminator internal to scope

Note 14: Decoupling 0.1 μF from GND to V_{CC} and V_{EE}

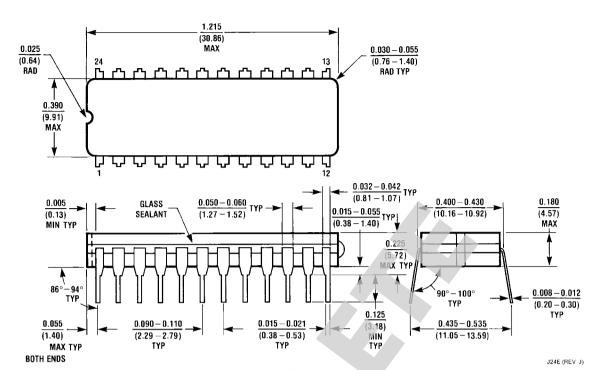
Note 15: All unused outputs are loaded with 50Ω to GND

Note 16: C_L = Fixture and stray capacitance ≤ 3 pF

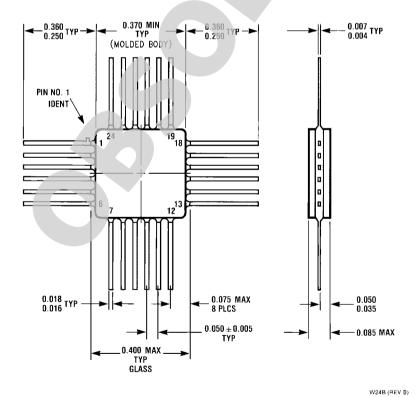
Note 17: Pin numbers shown are for flatpak; for DIP see logic symbol FIGURE 2. Propagation Delay and Transition Times



Physical Dimensions inches (millimeters) unless otherwise noted



24-Lead Ceramic Dual-In-Line Package (0.400 Wide) (D) NS Package Number J24E



24-Lead Quad Cerpak (F) NS Package Number W24B

Notes

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